
**Information technology — Digitally
recorded media for information
interchange and storage — Test
method for the estimation of lifetime of
optical disks for long-term data storage**

*Technologies de l'information — Supports pour l'échange
d'informations et le stockage enregistrés numériquement — Méthode
d'essai pour l'estimation de la durée de vie de disques optiques pour le
stockage à long terme*





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